



MOS-AK

Review&Outlook

Dr. Min Zhang

Dr. Wlodek Grabinski

Arbeitskreis Modellierung von Systemen und Parameterextraktion
Modeling of Systems and Parameter Extraction Working Group



Organizer:



Sponsors:





MOS-AK Modeling Events 2020-2021

- ❑ 14th US MOS-AK Workshop, Silicon Valley (US) Dec. 2021
in timeframe of IEDM and Q4 CMC Meetings
- ❑ 19th MOS-AK at ESSDERC/ESSCIRC, Grenoble (F) Sept.6, 2021
- ❑ 5th Sino MOS-AK Xi'an (CN), Aug. 2021
- ❑ FOSS TCAD/EDA at 5NANO2021, Kottayam (IN) April, 2021
- ❑ 3rd MOS-AK at LAEDC (MX), (online) April 18 2021
- ❑ 1st MOS-AK Asia/South Pacific, (online) Feb. 25-26, 2021
- ❑ FOSDEM CAD/EDA DevRoom, ULB, (B) Feb. 6-7, 2021
- ❑ IEEE EDS MQ Compact Modeling, Dec. 17 2020
- ❑ 13th US MOS-AK Workshop, Silicon Valley (US) Dec. 10-11, 2020
- ❑ MOS-AK Workshop, Giessen (D), Sept.29-30 - Oct.1, 2020
- ❑ 18th MOS-AK Workshop at ESSDERC/ESSCIRC, Sept. 14, 2020
- ❑ 2nd MOS-AK at LAEDC, Costa Rica, Febr.25, 2020

MOS-AK China history

1st compact model workshop



2nd compact model workshop



MOS-AK 上海 2016



MOS-AK 杭州 2017



MOS-AK 北京 2018



MOS-AK 成都 2019



MOS-AK China breakthrough 1



Question:

Prof. Yuehang Xu

from UESTC

Author Names	Website Link	Title
Dai, Kehan; Sang, Lei; Zhao, haojie; zhang, jie	https://onlinelibrary.wiley.com/doi/abs/10.1002/mop.32323	A modified T-type equivalent circuit model for stretchable microstrip line
Gao, Libo; Du, Chuanhua; Bu, Jianhui; Li, Jiangjiang; Ma, Quangang; Zhao, Fazhan; Gao, Jiantou; Li, Duoli; Zeng, Chuanbin; Zheng, Chao; Han, Zhengsheng; Luo, Jiajun	https://onlinelibrary.wiley.com/doi/10.1002/mop.32317	A transient ionizing radiation SPICE model for PDSOI MOSFET
Yan, Lixi; Li, Tianyu; Kalfass, Ingmar	https://onlinelibrary.wiley.com/doi/10.1002/mop.32119	Characterization and modeling of the reverse behavior of a vertical power MOSFET
Zhanfei, Chen; Sun, Lingling; Liu, Jun	https://onlinelibrary.wiley.com/doi/10.1002/mop.32208	A comparison of dynamic thermal characteristics of planar and Fin GaN HEMTs
Guo, Ao; Shang, Enming; Hu, Shao-Jian; Chen, Shoumian	https://onlinelibrary.wiley.com/doi/10.1002/mop.32217	TCAD-based statistical modeling methodology for nanoscale FinFET variability
Xie, Chengcheng; Yu, Gang; Zhang, Ziheng; Wang, Huanpeng; Li, Youda; Wu, Yunqiu; Guo, Yunchuan; min, xu; Xu, Yuehang	https://onlinelibrary.wiley.com/doi/10.1002/mop.32376	A microwave amplifier behavioral model capable of cascade simulation
Zhu, Guiqiang; chang, chen; Xu, Yuehang; Zhang, Ziheng; AL-saman, Amgad; Lin, Fujiang	https://onlinelibrary.wiley.com/doi/10.1002/mop.32404	A millimeter-wave scalable small-signal modeling approach based on FW-EM for AlGaIn/GaN HEMT up to 110 GHz
Zhao, Ziyue; Lu, Yang; ma, xiaohua; Zhang, Hengshuang; Yi, ChuPeng; Wang, Yuchen; Hao, Yue	https://onlinelibrary.wiley.com/doi/10.1002/mop.32497	Highly accurate GaN HEMT model based on the Angelov model with error compensation



增加国内交流&国内外资源共享

1. BTI reliability model from institute (design for reliability)
2. GaN model extraction software from university
3. Python language based software from startup

MOS-AK China breakthrough 2

“A Unified Physical BTI Compact Model in Variability-Aware DTCO Flow: Device Characterization and Circuit Evaluation on Reliability of Scaling Technology Nodes”的论文入选2021 VLSI Technology。微电子所博士生赵莹为第一作者，汪令飞副研究员、李泠研究员和刘明院士为通讯作者。

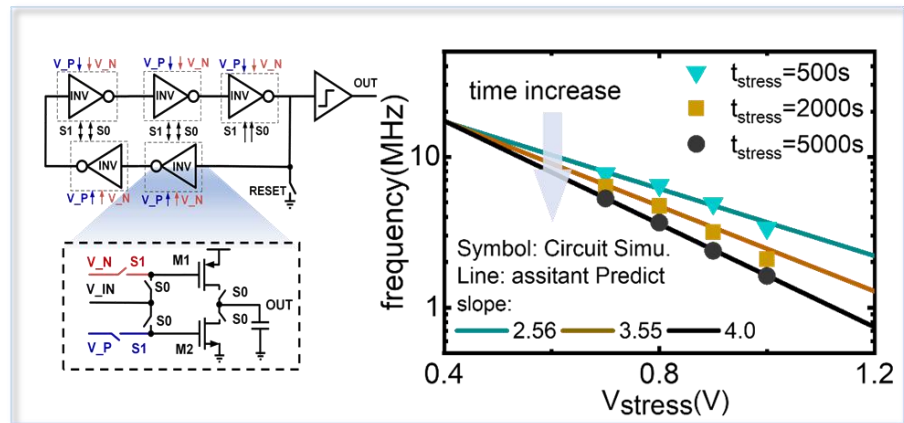
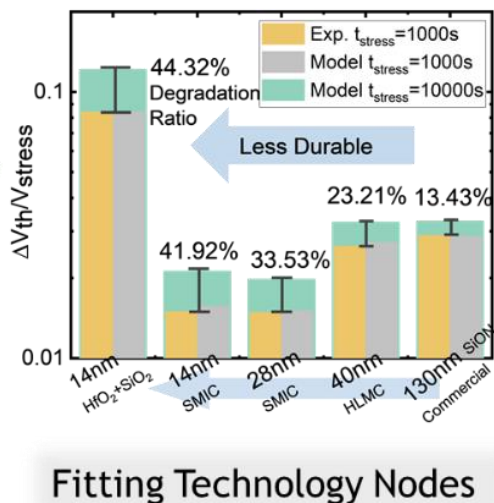
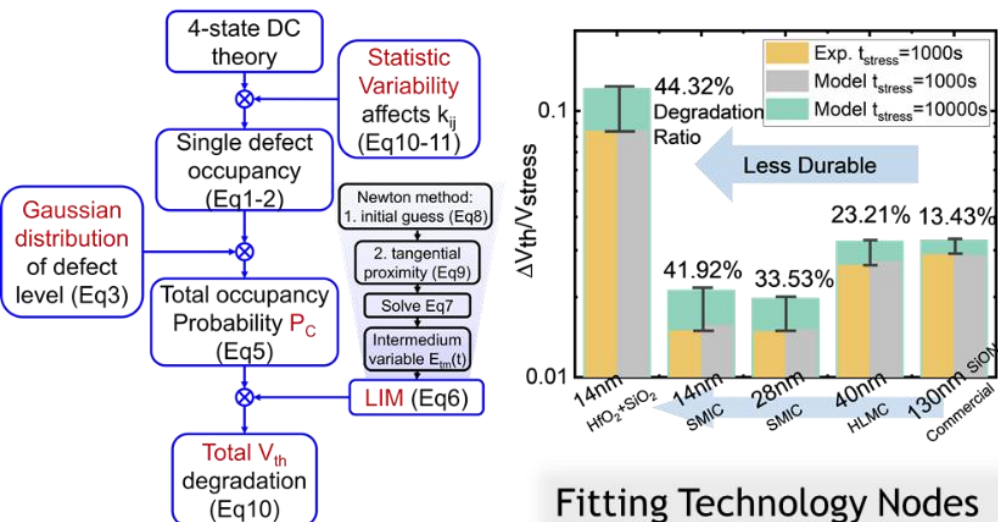
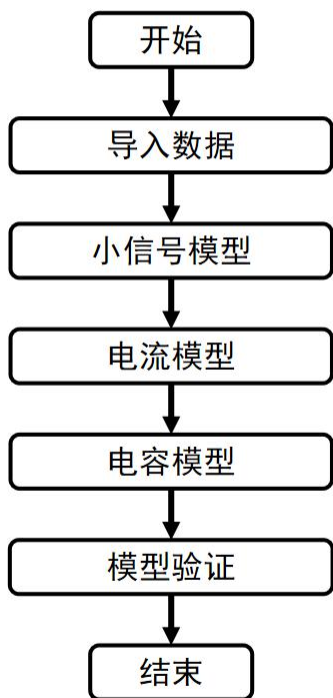


图1 基于4-state缺陷中心的BTI紧凑模型，可适用多种工艺节点并给出耐久性分析

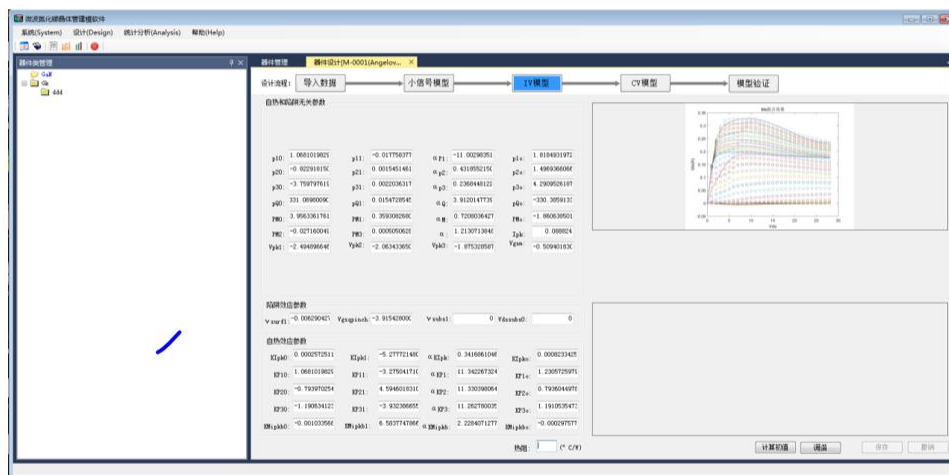
图2 嵌入了BSIM-CMG用于器件及电路老化性能的动态时间演化和预测分析

偏置温度不稳定(BTI)效应是集成电路(IC)器件可靠性的关键问题之一，该团队开发了一个统一的物理和统计紧凑模型，可以预测BTI对不同工艺节点的器件及电路（低至14nm）的影响，包含复杂的应力/恢复模式表征、超长期老化预测和工艺统计变量(TSV)的影响，实现cycle to cycle/device to device的可靠性评估。该模型基于2/4态的缺陷中心(DC)理论，针对缺陷的物理特性(如能级分布、占据概率等)建模。通过TCAD仿真验证和对鳍状场效应晶体管(FinFET)、平面晶体管等可靠性实验测试结果的校准，成功地嵌入了BSIM-CMG通用模型，用于器件及电路的动态时间演化和动态电压缩放分析。这种物理的、可变性的和具有耐久性感知的紧凑模型有潜力将VLSI可靠性设计技术协同优化(DTCO)流程提升到下一代技术节点。



模型参数提取流程

氮化镓晶体管模型参数提取软件



- 支持Focus测试系统数据导入;
- 界面简单、操作便捷;
- 每一步含自动参数提取;
- 支持ADS等软件的PDK自动生成。

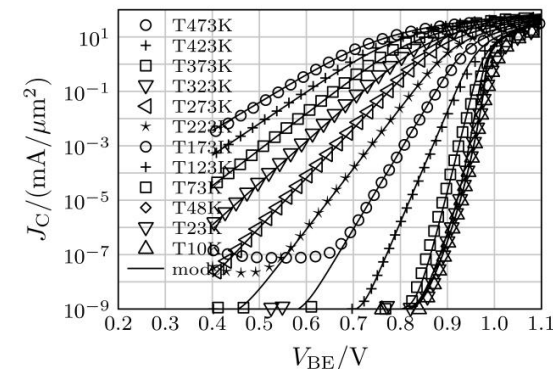
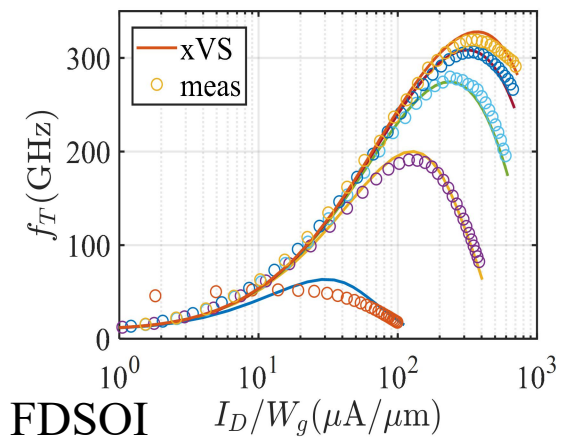
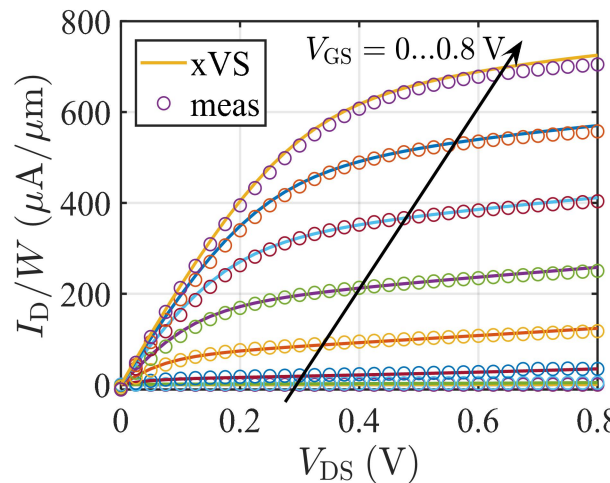
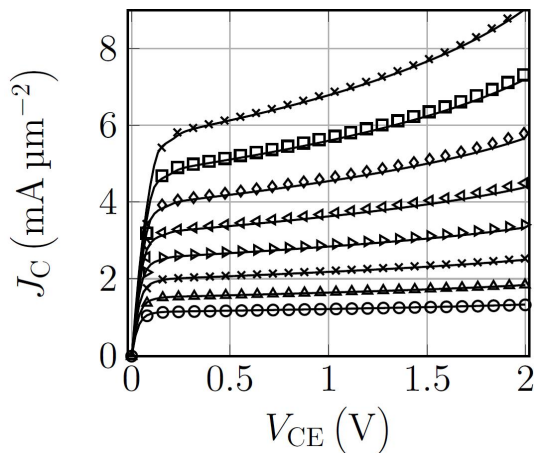
基于第三代半导体的设计应用也越来越广泛，需要好的PDK来减少芯片time to market

(小而美是国内需要的，也是值得支持的)

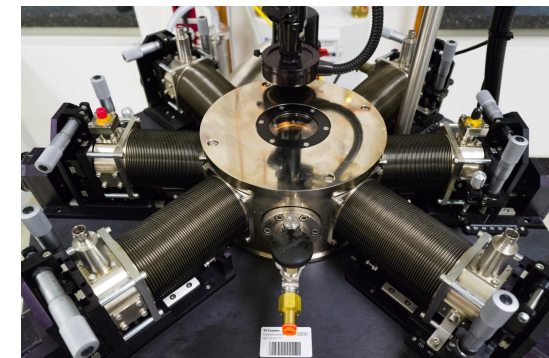
MOS-AK China breakthrough 2

SemiMod – DMT

DMT is **python based**, which is very good for data handling. Regarding Python: Python is the most flexible and widely spread high-level programming language in the world, it has the most extensive set of open-source libraries for all kinds of purposes. Key libraries using are scipy, numpy and pandas.

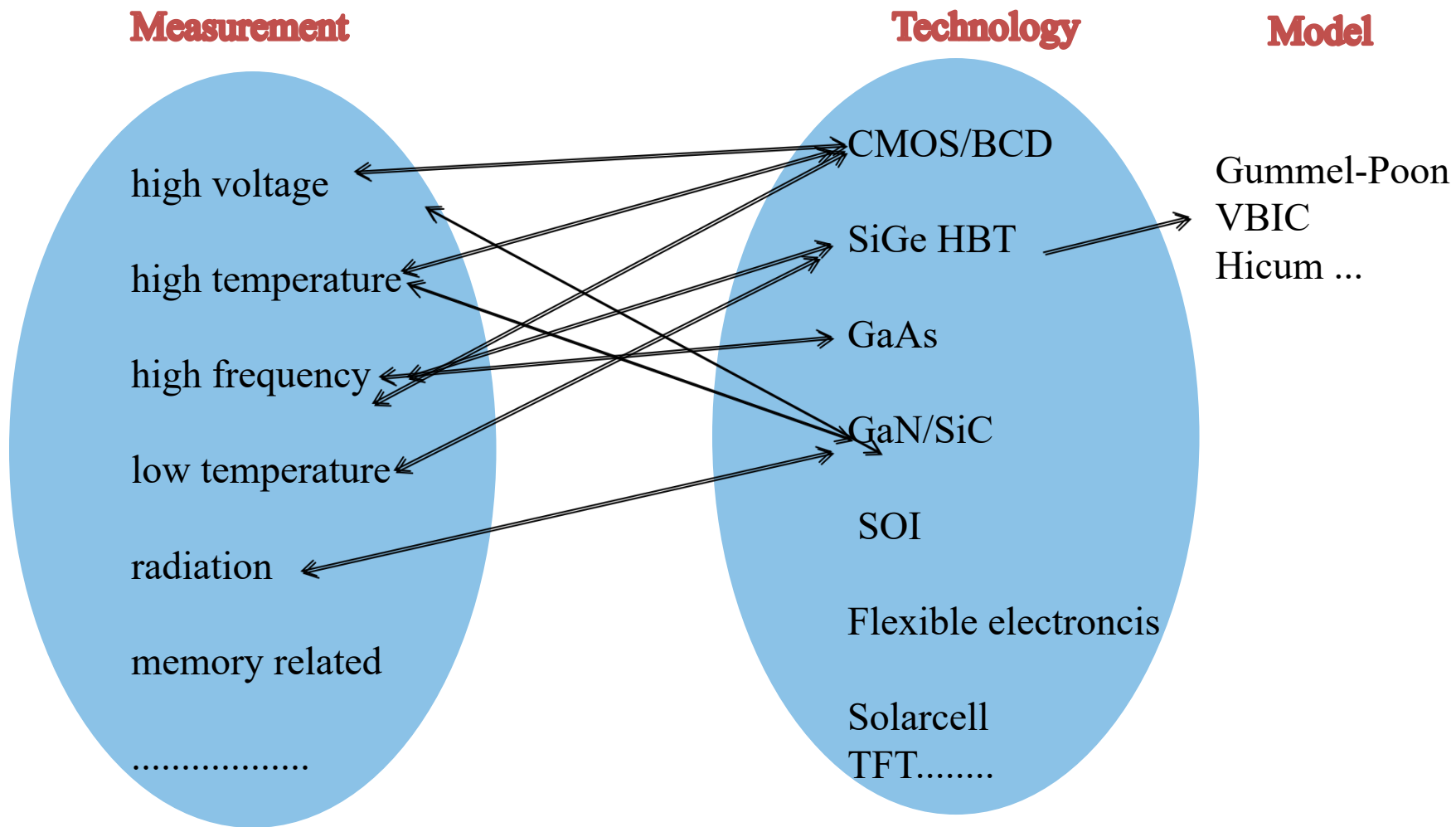


SiGe HBT from 10K to 473K



MOS-AK China breakthrough 2

Everyone is with strong point or advantage, need more communication:



no one is expert for all fields

1. Plan to give 30 -60 minutes for resource sharing session , open to all , welcome institute, university & start up to make presentation. Special resources or capability in the field of Measurement, Modeling, Device design , EDA tool innovation and so on. (MOS-AK 2022开始, 组织1-3 个单位 展示有模型相关的特色资源或者技能)
2. Welcome all EDA/Design houses/Foundry to pass down request info related to the measurement, modeling, design related, which will be open to MOS-AK platform (欢迎半导体相关企业, 把模型相关需求给到MOS-AK, 让参与人员更了解市场和合作机会)

Wish you have a fruitful learning day &

more open minded after MOS-AK 西安